

Application/Control No.	Applicant(s)/Patent under Reexamination
10/656,467	BELL ET AL.
Examiner	Art Unit
Binh X. Tran	1765

1,1	SEARCHED				
Class	Subclass	Date	Examiner		
438	709	8/24/2005	ВТ		
438	714	8/24/2005	ВТ		
438	724	8/24/2005	вт		
438	725	8/24/2005	вт		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated search using USPAT, USPG- PUB, JPO, EPO, DERWENT databases	8/24/2005	вт		
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